Se	arcn	Notes	

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/679,789	SCOONES ET AL.	
	Examiner	Art Unit	_
	Y J Han	2838	

	SEAR	CHED	
Class	Subclass	Date	Examiner
323	270		
	271		
	273		
	274		
	275		
	277		
	280		
	281	3/05	gra
Search	281 updat	ed	1
	•	6/05	974

IN.	TERFERENCE	CE SEARCH	IED
Class	Subclass	Date	Examiner
32 <i>3</i>	280		
	274	6/05	91

(INCLUDING SE	H NOTES ARCH STRAT	EGY)
	DAT	TE EXMR
•		
•		
·····	,	
·		
,		·
· •		